## **Special Session 4B: Elevator Talks**

## **Organizer & Moderator:**

Jennifer Dworak (Southern Methodist University)

## **Presenters:**

- Forecast METER Ronald (Shawn). Blanton (Carnegie Mellon University)
- Functional Observable Fault (FOF): A Fault Model for Logical Bugs as well as Faults *Masahiro Fujita (University of Tokyo)*
- Impact of Process Variation on Delay Test Quality Kazumi Hatayama (NAIST)
- Accelerating NBTI Aging to Wear out Digital Circuits Naghmeh Karimi (NYU-Poly)
- Privilege Escalation Attack through Address Space Identifier Corruption in Untrusted Modern Processors *Michail Maniatakos (NYU-Abu Dhabi)*
- Radiation Tolerant Reconfigurable Payload Data Processing Units for Space Applications Antonis Paschalis (University of Athens)
- Delay Faults: Are We Looking for the Right Ones?
  Adit Singh (Auburn University)
- Techniques to Leverage Test Speed of Wide Band Circuit/System *Tian Xia (University of Vermont)*

